



US00D677389S

(12) **United States Design Patent**
Koivulehto et al.

(10) **Patent No.:** **US D677,389 S**
(45) **Date of Patent:** **** Mar. 5, 2013**

- (54) **ANALYTICAL TEST CARD**
- (75) Inventors: **Taru Koivulehto**, Espoo (FI); **Outi Jauri**, Espoo (FI); **Sami Oittinen**, Espoo (FI); **Anne-Marie Ackermann**, Espoo (FI); **Helvi Mustonen**, Espoo (FI); **Leena Aro**, Espoo (FI); **Veli-Mies Häivä**, Espoo (FI)
- (73) Assignee: **Orion Diagnostica Oy**, Espoo (FI)

D462,125 S *	8/2002	Pham	D24/225
D468,437 S *	1/2003	McMenamy et al.	D24/223
D468,441 S *	1/2003	Pham	D24/225
D491,276 S *	6/2004	Langille	D24/225
D561,187 S *	2/2008	Kunioka et al.	D14/436
D569,990 S *	5/2008	Fisch	D24/225
D587,145 S *	2/2009	Nakatsubo et al.	D10/52
D588,029 S *	3/2009	Nakatsubo et al.	D10/56
D589,380 S *	3/2009	Nakatsubo et al.	D10/52
D596,753 S *	7/2009	LaStella	D24/216
D596,965 S *	7/2009	Nakatsubo et al.	D10/52
D598,121 S *	8/2009	LaStella	D24/216
D623,303 S *	9/2010	Koivulehto et al.	D24/186

(**) Term: **14 Years**

* cited by examiner

(21) Appl. No.: **29/351,477**

Primary Examiner — T. Chase Nelson

(22) Filed: **Dec. 7, 2009**

Assistant Examiner — Mark Cavanna

(51) **LOC (9) Cl.** **24-01**

(74) *Attorney, Agent, or Firm* — Klauber & Jackson LLC

(52) **U.S. Cl.** **D24/186**

(57) **CLAIM**

(58) **Field of Classification Search** D10/52,
D10/53, 56; 73/73, 29.02, 29.04; 116/200,
116/207, 216, 217, 219, 201; 374/102, 104,
374/106, 161, 162; 422/55, 61; D24/216,
D24/232–231, 107, 223, 225–226, 186; D19/1,
D19/10; 206/232; 435/33, 36; D20/40;
436/518; D14/436

The ornamental design for an analytical test card, as shown and described.

See application file for complete search history.

DESCRIPTION

(56) **References Cited**

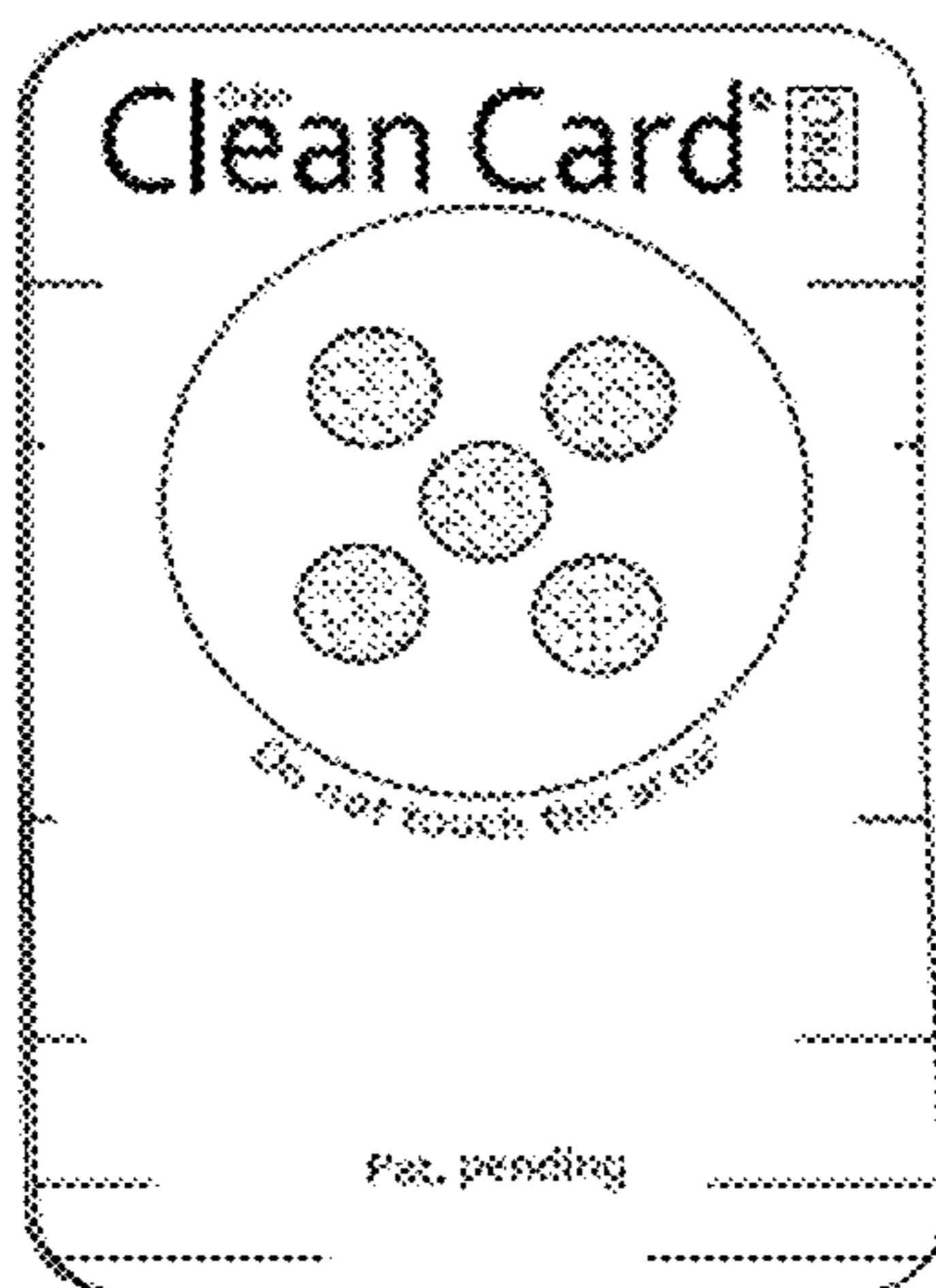
U.S. PATENT DOCUMENTS

D260,153 S *	8/1981	Koltys	D19/10
D284,215 S *	6/1986	Sherwin et al.	D24/225
D334,597 S *	4/1993	Busquets	D20/40
D392,391 S *	3/1998	Douglas et al.	D24/225
D396,882 S *	8/1998	Neal, Jr.	D19/10
D404,812 S *	1/1999	Cipkowski	D24/107
D423,110 S *	4/2000	Cipkowski	D24/223
D430,303 S *	8/2000	Cipkowski	D24/226
D456,910 S *	5/2002	Clark et al.	D24/225
6,406,922 B2 *	6/2002	Casterlin et al.	436/518
D461,251 S *	8/2002	Pham	D24/225
D461,561 S *	8/2002	Pham	D24/225
D461,906 S *	8/2002	Pham	D24/225

FIG. 1 is a front view of a analytical test card of our new design;
 FIG. 2 is a rear view thereof;
 FIG. 3 is a perspective view showing the top and front thereof;
 FIG. 4 is a perspective view showing the top and rear thereof;
 FIG. 5 is a left side perspective view of the analytical test card with the left side of the card bent into a curvature, showing the left side and rear thereof;
 FIG. 6 is a right side perspective view of the analytical test card with the left side of the card bent into a curvature, showing the right side and rear thereof; and,
 FIG. 7 is a left side end view showing the left side and front thereof.

The trademarked portions forming part of the claimed design are a registered trademark of Orion Diagnostica Oy, Koivu-Maankaantie 6B, FI-002200 Espoo, Finland.

1 Claim, 4 Drawing Sheets



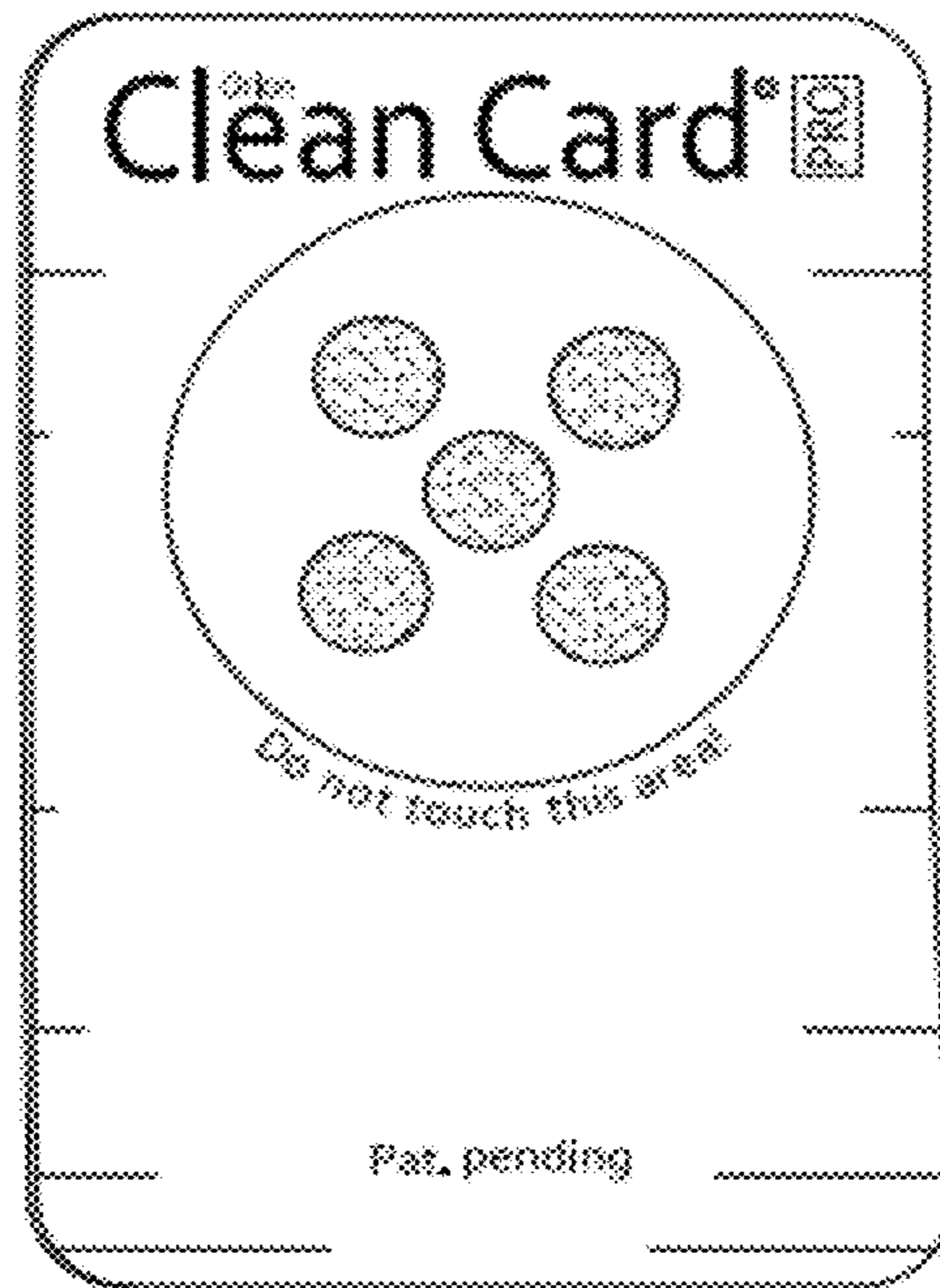


FIG. 1

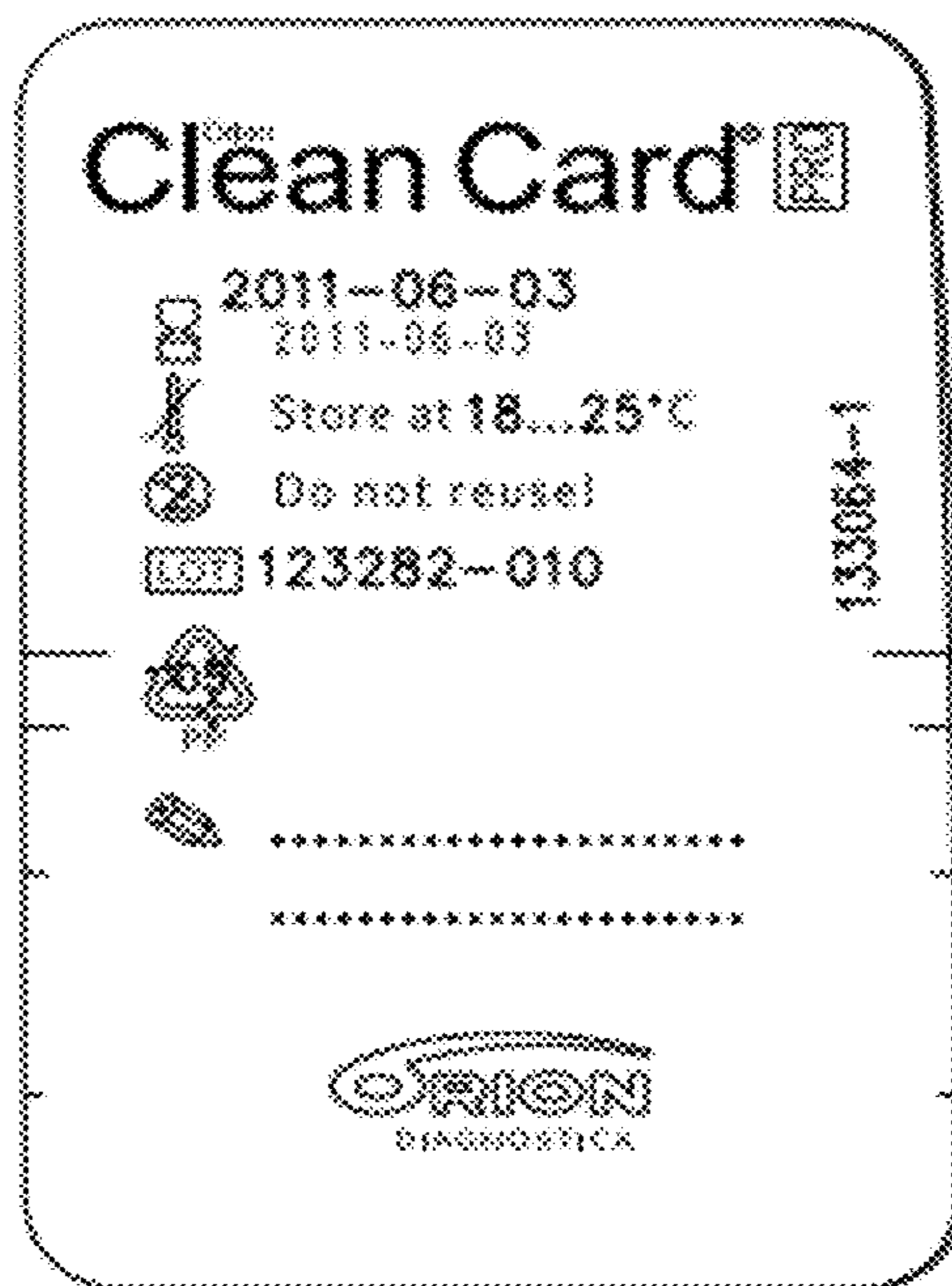


FIG. 2

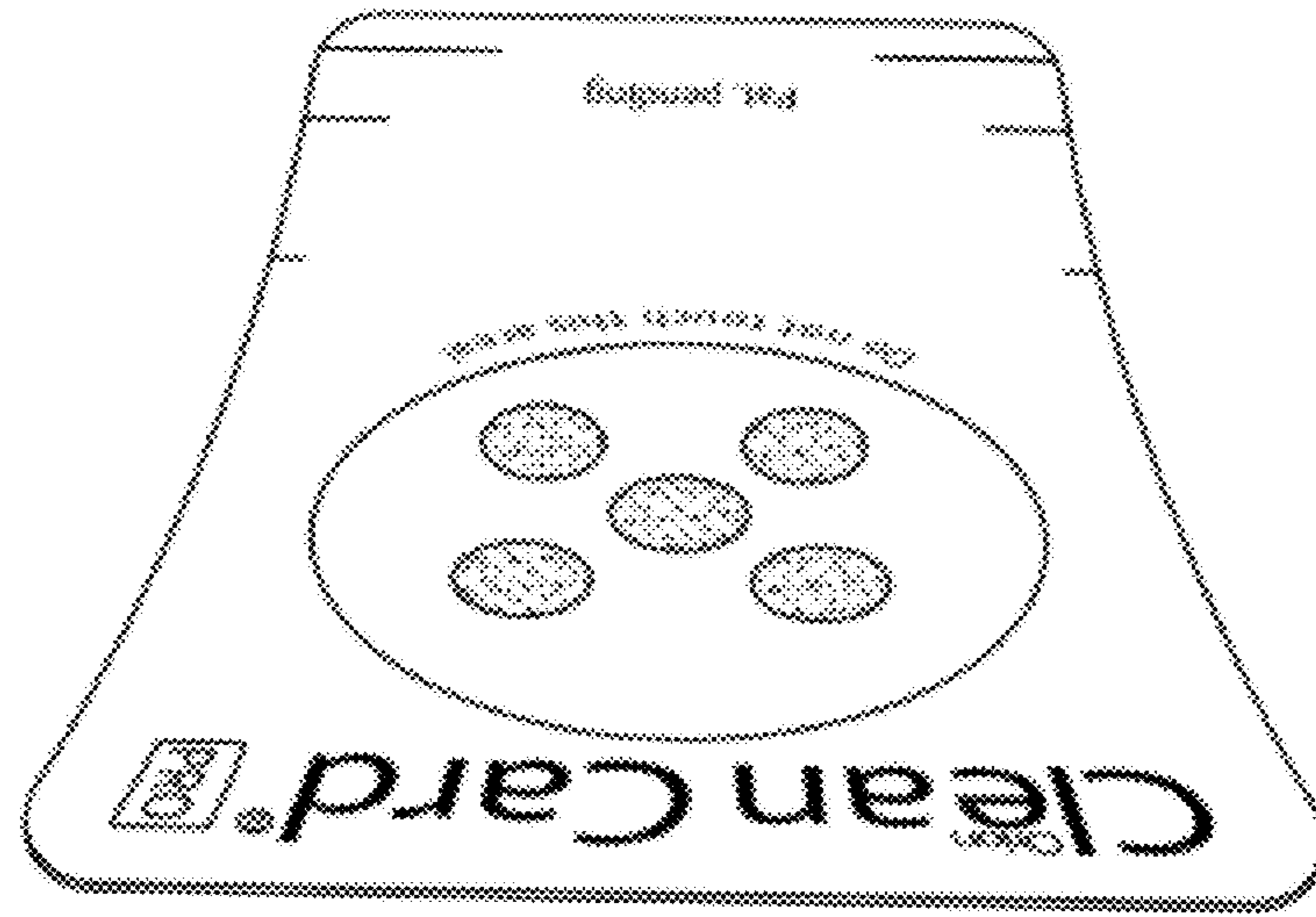


FIG. 3

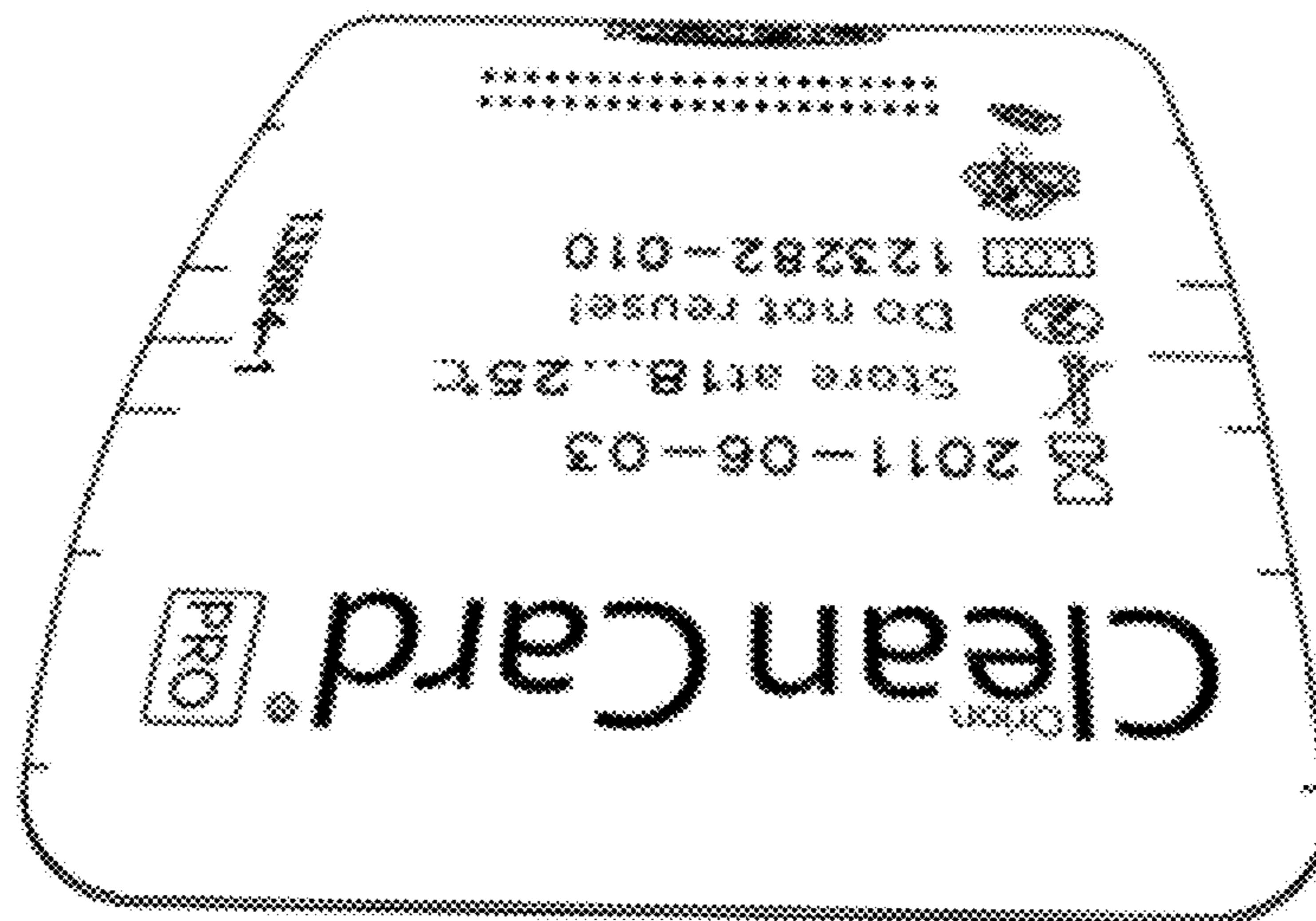


FIG. 4

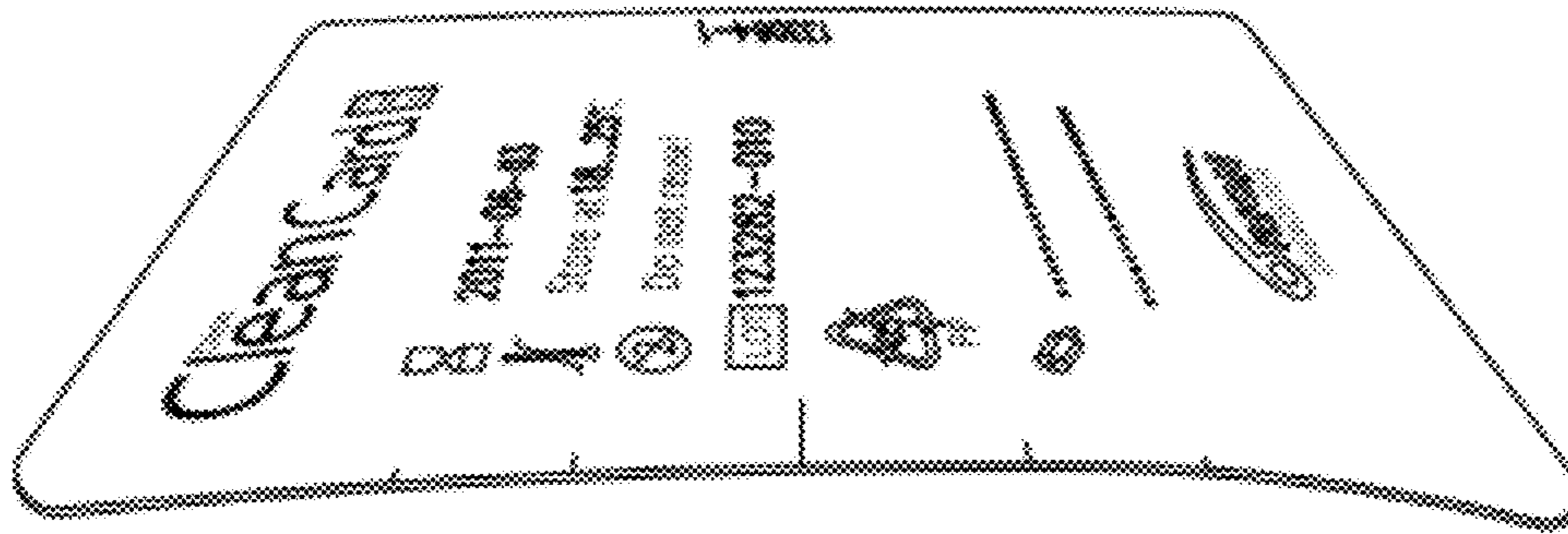


FIG. 5

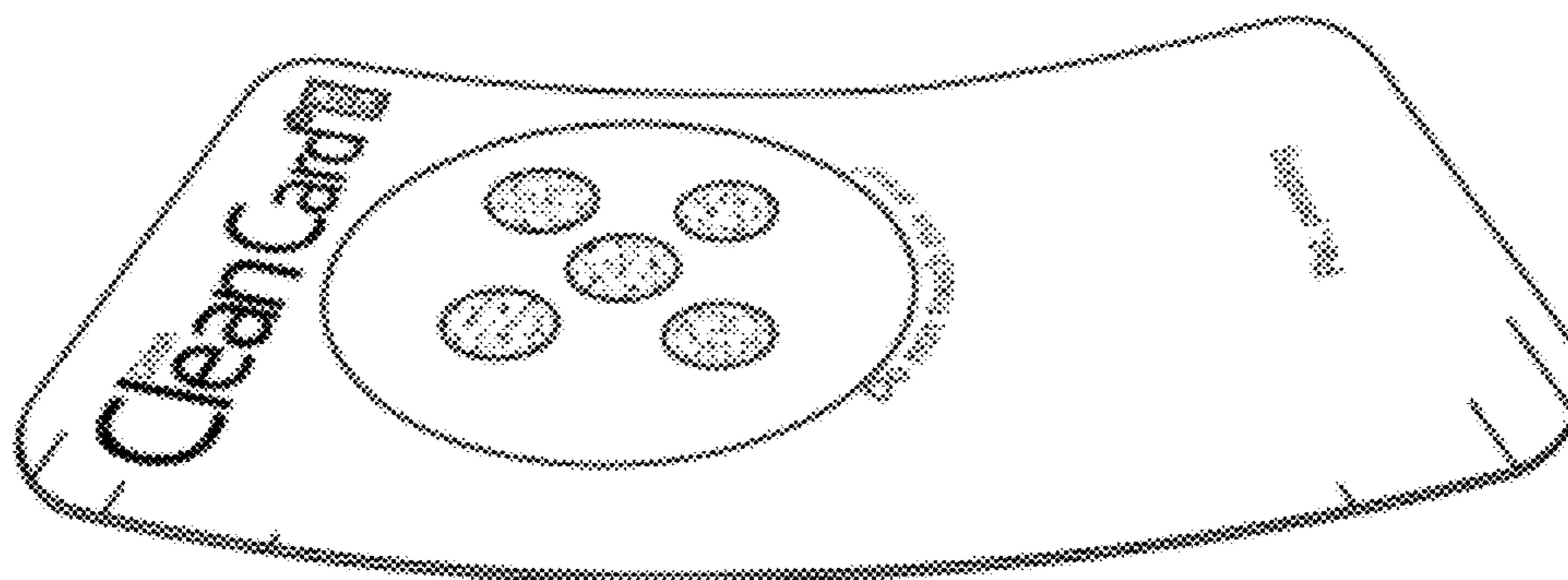


FIG. 6

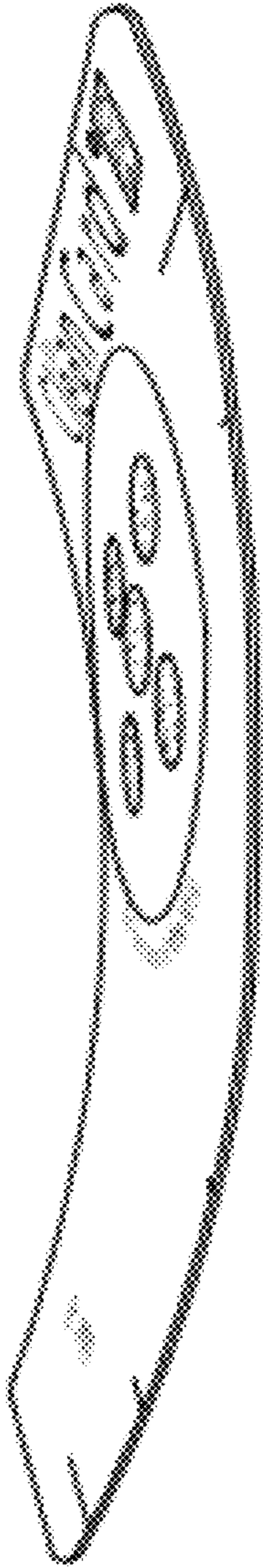


FIG. 7